

Data sheet acquired from Harris Semiconductor SCHS045C – Revised October 2003

# **CMOS Multifunction Expandable 8-Input Gate**

High-Voltage Types (20-Volt Rating)

© CD4048B is an 8-input gate having four control inputs. Three binary control inputs — Ka, Kb, and Kc — provide the implementation of eight different logic functions. These functions are OR, NOR, AND, NAND, OR/AND, OR/NAND, AND/OR and AND/NOR.

A fourth control input, Kd, provides the user with a 3-state output. When control input Kd is high, the output is either a logic 1 or a logic 0 depending on the inner states. When control input Kd is low, the output is an open circuit. This feature enables the user to connect this device to a common bus line.

MAXIMUM RATINGS, Absolute-Maximum Values:

DC SUPPLY-VOLTAGE RANGE, (VDD)

POWER DISSIPATION PER PACKAGE (PD):

DEVICE DISSIPATION PER OUTPUT TRANSISTOR

LEAD TEMPERATURE (DURING SOLDERING):

In addition to the eight input lines, an EXPAND input is provided that permits the user to increase the number of inputs into a CD4048B (see Fig. 2). For example, two CD4048Bs can be cascaded to provide a 16-input multifunction gate. When the EXPAND input is not used, it should be connected to  $V_{SS}$ .

The CD4048B-series types are supplied in 16-lead hermetic dual-in-line ceramic packages (F3A suffix), 16-lead dual-in-line plastic packages (E suffix), 16-lead small-outline packages (M, M96, MT, and NSR suffixes), and 16-lead thin shrink small-outline packages (PW and PWR suffixes).

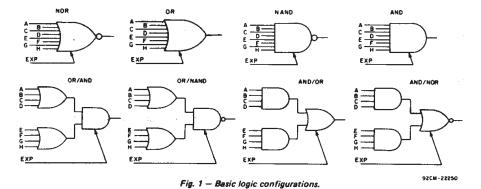
# INPUTS FOR THE PROPERTY OF THE

#### Features:

- Three-state output
- Many logic functions available in one package
- Standardized, symmetrical output characteristics

CD4048B Types

- 100% tested for quiescent current at 20 V
- Maximum input current of 1 μA at 18 V (full package-temperature range), 100 nA at 18 V and 25°C
- Noise margin (full package-temperature range) = 1 V at V<sub>DD</sub>=5 V, 2 V at V<sub>DD</sub> = 10 V, 2.5 V at V<sub>DD</sub>=15 V
- 5-V, 10-V, and 15-V parametric ratings
- Meets all requirements of JEDEC Tentative Standard No. 13B, "Standard Specifications for Description of 'B' Series CMOS Devices"



Voltages referenced to VSS Terminal) .....-0.5V to +20V

OPERATING-TEMPERATURE RANGE (TA).....-55°C to +125°C

STORAGE TEMPERATURE RANGE (T<sub>stg</sub>).....-65°C to +150°C

INPUT VOLTAGE RANGE, ALL INPUTS -0.5V to V<sub>DD</sub> +0.5V DC INPUT GURRENT, ANY ONE INPUT +10mA

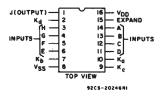
#### **RECOMMENDED OPERATING CONDITIONS**

For maximum reliability, nominal operating conditions should be selected so that operation is always within the following ranges:

CHARACTERISTIC	LIMI	TS	
CHARACTERISTIC	MIN.	MAX.	UNITS
Supply-Voltage Range (For $T_A$ = Full Package Temperature Range)	3	18	V

# Applications:

- Selection of up to 8 logic functions
- Digital control of logic
- General-purpose gating logic
  - Decoding
- Encoding



**TERMINAL ASSIGNMENT** 

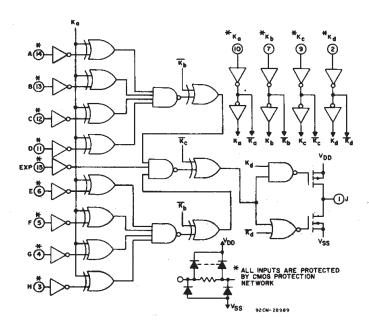
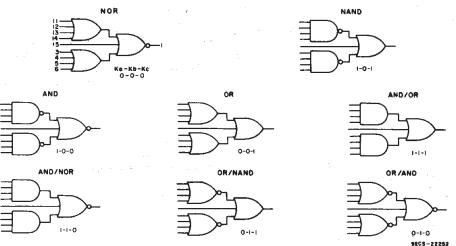


Fig. 2 - Logic diagram.



 ${\it Fig.~3-Actual-circuit~logic~configurations.}$ 

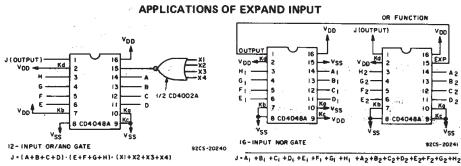


Fig. 4-12-input OR/AND gate.

Fig. 5 - 16-input NOR gate.

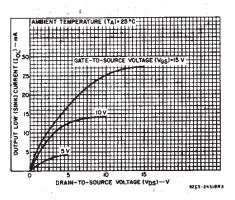


Fig. 6 — Typical output low (sink) current characteristics.

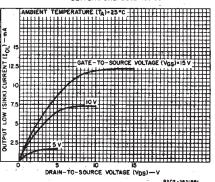


Fig. 7 — Minimum output low (sink) current characteristics.

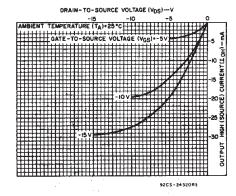


Fig. 8 — Typical output high (source) current characteristics.

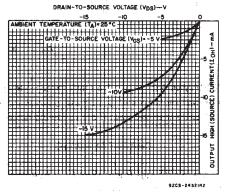


Fig. 9 – Minimum output high (source) current characteristics.

# CD4048B Types

# STATIC ELECTRICAL CHARACTERISTICS

			_								1
CHARACTER-	CONI	DITIO	ļs	LIMI	TS AT	INDICAT	FED TE	MPERA	TURES	(°C)	
ISTIC	V <sub>O</sub>	VIN	VDD					[	+25		UNITS
	(v)	(V)	(V)	55	40	+85	+125	Min.	Тур.	Max.	
Quiescent Device	-	0,5	5	0.25	0.25	7.5	7.5	_	0.01	0.25	
Current,		0,10	10	0.5	0.5	15	- 15	-	0.01	0.5	1
IDD Max.		0,15	15	1	1	30	30	-	0,01	1	μΑ
	_	0,20	20	5	5	150	150	-	0.02	5	
Output Low (Sink) Current IOL Min.	0.4	0,5	5	0.64	0.61	0.42	0.36	0.51	1	·	
	0.5	0,10	10	1.6	1.5	1.1	0.9	1.3	2.6	_	1
	1.5	0,15	15	4.2	4	2.8	2.4	3.4	6.8	_	]
Output High	4.6	0,5	5	-0.64	-0.61	-0.42	-0.36	-0.51	1	· –	mA
(Source)	2.5	0,5	5	-2	-1.8	-1.3	-1.15	-1.6	-3.2	-	1
Current, IOH Min.	9.5	0,10	10	~1.6	-1.5	-1.1	-0.9	-1.3	-2.6	-	
тон жит.	13.5	0,15	15	-4.2	-4	-2.8	-2.4	-3.4	-6.8	-	
Output Voltage:		0,5	5		0	.05		_	0	0.05	
Low-Level, VOL Max.	-	0,10	10		0	.05		_	0	0.05	[ ]
VUL Max.	-	0,15	15	0.05				÷	0	0.05	v l
Output Voltage:	-	0,5	5		4	95	1 - 1	4.95	5	-	
High-Level,	- "	0,10	10		9	95		9.95	10		
VOH Min.		0,15	15		14	.95		14.95	15	-	
Input Low	0.5,4.5	_	5		1	.5		-	_	1.5	
Voltage,	1,9		10			3			_	3	l i
VIL Max.	1.5,13.5	_	15			4		-		4	١ ا
Input High	0.5,4.5	_	5		. 3	.5		3.5	<u> </u>	_	V
Voltage,	1,9		10			7		7	_	_	
VIH Min.	1.5,13.5	-	15		1	1		11		_	
Input Current IJN Max.		0,18	18	±0,1	±0.1	±1	±1	-	±10 <sup>-5</sup>	±0.1	μΑ
3-State Output Current, IOUT	0,18	0,18	18	±0.4	±0.4	±12	±12	<b>-</b>	±10 <sup>-4</sup>	±0.4	μΑ

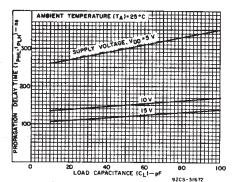


Fig. 10 -- Typical propagation delay time (logic inputs to output) as a function of load capacitance.

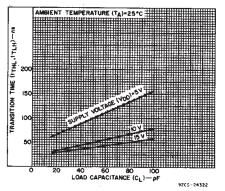


Fig. 11 - Typical transition time vs. load capacitance.

#### **IMPLEMENTATION OF EXPAND INPUT FOR 9 OR MORE INPUTS**

OUTPUT FUNCTION	FUNCTION NEEDED AT EXPAND INPUT	OUTPUT BOOLEAN EXPRESSION
NOR	OR	J=(A+B+C+D+E+F+G+H)+(EXP)
OR	OR	J=(A+B+C+D+E+F+G+H)+(EXP)
AND	NAND	J=(ABCDEFGH)·(EXP)
NAND	NAND	J=(ABCDEFGH)·(EXP)
OR/AND	NOR	J=(A+B+C+D) (E+F+G+H) (EXP)
OR/NAND	NOR	J=(A+B+C+D)·(E+F+G+H)·(EXP)
AND/NOR	AND	J=(ABCD)+(EFGH)+(EXP)
AND/OR	AND	J=(ABCD)+(EFGH)+(EXP)

Note: (EXP) designates the EXPAND function (i.e.,  $x_1+x_2+\ldots x_N$ ).

### NOTE: Refer to FUNCTION TRUTH TABLE for connection of unused inputs.

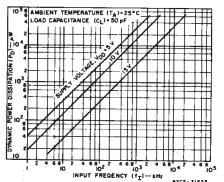


Fig. 12 — Typical power dissipation as a function of input frequency.

# CD4048B Types

DYNAMIC CHARACTERISTICS at TA=25°C, CL=50 pF, Input t<sub>r</sub>,t<sub>f</sub>=20 ns, RL=200 k $\Omega$  unless otherwise specified

	TEST CONDI	TIONS	LIM	ITS	
CHARACTERISTIC		V <sub>DD</sub>	All Packs	ge Types	UNITS
		V	Тур.	Max.	
Propagation Delay: tpHL,tpLH		5	300	600	
Inputs to Output and		10	150	300	
Ka to Output		15	120	240	
Kb to Output		5	225	450	
		10	85	170	
		15.	55	110	
Kc to Output		5	140	280	
		10	50	100	
		15	40	80	
Expand Input to Output		5	190	380	ns
	<u> </u>	10	90	180	
		15	65	130	
3-State Propagation Delay:		5	80	160	
Kd to Output tpHZ,tpLZ	R <sub>L</sub> =1 kΩ	10	35	70	
<sup>t</sup> PZH, <sup>t</sup> PZL	See Fig.21	15	25	50	
Transition Time: tTHL,tTLH		5	100	200	,
11190 11911	!	10	50	100	
		15	40	80	
Input Capacitance: C <sub> </sub>	Any inp	ut	5	7	pF
3-State Output Capacitance		:	5	10	pr

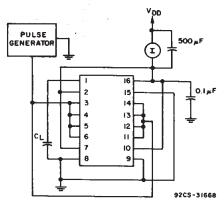


Fig. 13 – Dynamic power dissipation test circuit.

#### **FUNCTION TRUTH TABLE**

OUTPUT FUNCTION	BOOLEAN EXPRESSION	Ka	Кb	Kc	UNUSED				
NOR	J≈A+B+C+D+E+F+G+H	0	0	0	V <sub>SS</sub>				
OR	J=A+B+C+D+E+F+G+H	0	0	1	VSS				
OR/AND	J=(A+B+C+D)•(E+F+G+H)	0	1	0	V <sub>SS</sub>				
OR/NAND	J=(A+B+C+D)·(E+F+G+H)	0	1	1	V <sub>SS</sub>				
AND	J=ABCDEFGH	1	0	0	V <sub>DD</sub>				
NAND	J=ABCDEFGH	1	0	1	V <sub>DD</sub>				
AND/NOR	J=ABCD+EFGH	1	1	0	V <sub>DD</sub>				
AND/OR	J=ABCD+EFGH	1	1	1	V <sub>DD</sub>				
K <sub>d</sub> =1 Normal Inverter Action									
K <sub>d</sub> =0 High Impedance Output									

EXPAND Input=0

\* See Figs. 1,2,3,4, and 5.

# TEST CIRCUITS - STATIC MEASUREMENTS

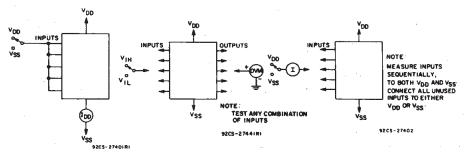


Fig. 14 — Quiescent device current test circuit.

Fig. 15 — Input voltage test circuit.

Fig. 16 - Input current test circuit.

#### **TEST CIRCUITS - DYNAMIC MEASUREMENTS**

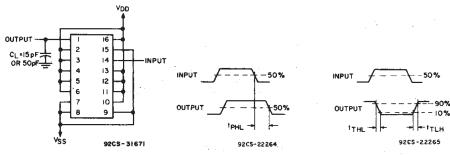


Fig. 17 — Test circuit for t<sub>PHL</sub>, t<sub>THL</sub>, end t<sub>TLH</sub> (AND) measurements.

Fig. 18 — Waveforms for  $t_{PHL}$  and  $t_{PHL}$  (AND).

Fig. 19 — Waveforms for  $t_{THL}$  and  $t_{TLH}$  (AND).

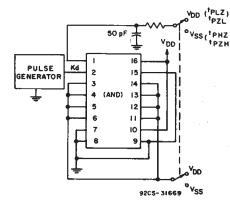


Fig. 20 — Test circuit for  $t_{PZL}$ ,  $t_{PZH}$ ,  $t_{PLZ}$ , and  $t_{PHZ}$  (AND).

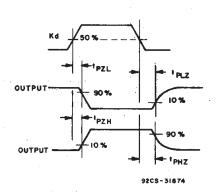
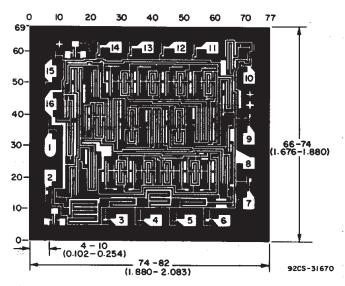


Fig. 21 — Waveforms for  $t_{PZL}$ ,  $t_{PZH}$ ,  $t_{PLZ}$ , and  $t_{PHZ}$  (AND).



Dimensions and pad layout for CD4048BH.

Dimensions in parantheses are in millimeters and are derived from the basic inch dimensions as indicated. Grid graduations are in mils  $(10^{-3})$  inch).

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#### PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan	Lead finish/ Ball material	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
CD4048BE	ACTIVE	PDIP	N	16	25	RoHS & Green	NIPDAU	N / A for Pkg Type	-55 to 125	CD4048BE	Samples
CD4048BF3A	ACTIVE	CDIP	J	16	1	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	CD4048BF3A	Samples
CD4048BM	LIFEBUY	SOIC	D	16	40	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-55 to 125	CD4048BM	
CD4048BM96	ACTIVE	SOIC	D	16	2500	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-55 to 125	CD4048BM	Samples
CD4048BPW	ACTIVE	TSSOP	PW	16	90	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-55 to 125	CM048B	Samples

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

- (3) MSL, Peak Temp. The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead finish/Ball material Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

# **PACKAGE OPTION ADDENDUM**

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#### OTHER QUALIFIED VERSIONS OF CD4048B, CD4048B-MIL:

Catalog: CD4048B

Military: CD4048B-MIL

NOTE: Qualified Version Definitions:

- Catalog TI's standard catalog product
- Military QML certified for Military and Defense Applications

# **PACKAGE MATERIALS INFORMATION**

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# TAPE AND REEL INFORMATION





	Dimension designed to accommodate the component width
B0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

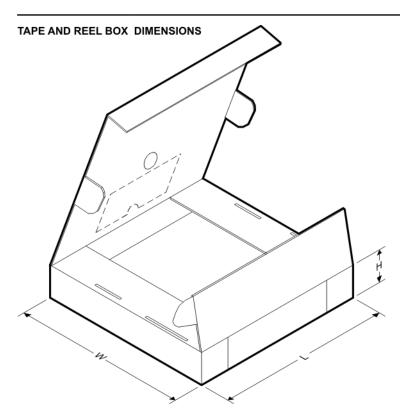
# QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



# \*All dimensions are nominal

Device	Package Type	Package Drawing			Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
CD4048BM96	SOIC	D	16	2500	330.0	16.4	6.5	10.3	2.1	8.0	16.0	Q1

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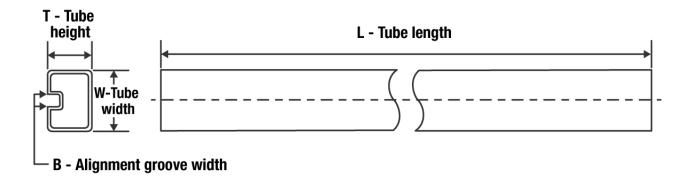
#### \*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
CD4048BM96	SOIC	D	16	2500	340.5	336.1	32.0

# PACKAGE MATERIALS INFORMATION

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# **TUBE**



#### \*All dimensions are nominal

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Device	Package Name	Package Type	Pins	SPQ	L (mm)	W (mm)	T (µm)	B (mm)
CD4048BE	N	PDIP	16	25	506	13.97	11230	4.32
CD4048BE	N	PDIP	16	25	506	13.97	11230	4.32
CD4048BM	D	SOIC	16	40	507	8	3940	4.32
CD4048BPW	PW	TSSOP	16	90	530	10.2	3600	3.5

# D (R-PDS0-G16)

# PLASTIC SMALL OUTLINE



- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.006 (0,15) each side.
- Body width does not include interlead flash. Interlead flash shall not exceed 0.017 (0,43) each side.
- E. Reference JEDEC MS-012 variation AC.





SMALL OUTLINE PACKAGE



- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

  2. This drawing is subject to change without notice.

  3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
- 5. Reference JEDEC registration MO-153.



SMALL OUTLINE PACKAGE



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



SMALL OUTLINE PACKAGE



NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.



# 14 LEADS SHOWN



- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- C. This package is hermetically sealed with a ceramic lid using glass frit.
- D. Index point is provided on cap for terminal identification only on press ceramic glass frit seal only.
- E. Falls within MIL STD 1835 GDIP1-T14, GDIP1-T16, GDIP1-T18 and GDIP1-T20.

# N (R-PDIP-T\*\*)

# PLASTIC DUAL-IN-LINE PACKAGE

16 PINS SHOWN



- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- Falls within JEDEC MS-001, except 18 and 20 pin minimum body length (Dim A).
- The 20 pin end lead shoulder width is a vendor option, either half or full width.



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